

<b>Notice of References Cited</b>	Application/Control No. 10/073,952	Applicant(s)/Patent Under Reexamination TAKAYAMA, NORIHISA	
	Examiner Ashish K. Thomas	Art Unit 2626	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0112010	08-2002	Soroker et al.	709/206
*	B	US-2002/0013817	01-2002	Collins et al.	709/206
*	C	US-2001/0034849	10-2001	Powers, Gene	713/202
*	D	US-2002/0129108	09-2002	Sykes, George H. JR.	709/206
*	E	US-2002/0042816	04-2002	Bae, Sang Geun	709/206
*	F	US-2002/0107928	08-2002	Chalon, Denis	709/206
*	G	US-6,732,101	05-2004	Cook, David P.	707/10
*	H	US-6,710,894	03-2004	Ogawa, Hidehiko	358/1.15
*	I	US-6,785,018	08-2004	Wakabayashi, Takefumi	358/1.15
*	J	US-2002/0188683	12-2002	LYTLE et al.	709/206
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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